Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/680,051	MIYATAKE ET AL.
Examiner	**Art Unit**
Hien N. Nguyen	2824

SEARCHED			
Class	Subclass	Date	Examiner
365	171	5/10/2005	HN
	158		
	189.08		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	**171**	5/12/2005	**HN**
	158		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	5/10/2005	HN